

Notice of References Cited	Application/Control No. 10/774,606	Applicant(s)/Patent Under Reexamination NAKAI, SHINYA	
	Examiner NGUYEN VO	Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0030555	03-2002	Mandai et al.	333/133
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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